# **MOSFET** – N-Channel, POWERTRENCH®, Power Stage, Asymetric Dual

#### **General Description**

This device includes two specialized N-Channel MOSFETs in a dual PQFN package. The switch node has been internally connected to enable easy placement and routing of synchronous buck converters. The control MOSFET (Q1) and synchronous SyncFET<sup>TM</sup> (Q2) have been designed to provide optimal power efficiency.

#### **Features**

O1: N-Channel

- Max  $r_{DS(on)} = 8 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 13 \text{ A}$
- Max  $r_{DS(on)}$  = 11 m $\Omega$  at  $V_{GS}$  = 4.5 V,  $I_D$  = 11 A Q2: N-Channel
- Max  $r_{DS(on)} = 2.6 \text{ m}\Omega$  at  $V_{GS} = 10 \text{ V}$ ,  $I_D = 23 \text{ A}$
- Max  $r_{DS(on)} = 3.5 \text{ m}\Omega$  at  $V_{GS} = 4.5 \text{ V}$ ,  $I_D = 21 \text{ A}$
- Low Inductance Packaging Shortens Rise/Fall Times, Resulting in Lower Switching Losses
- MOSFET Integration Enables Optimum Layout for Lower Circuit Inductance and Reduced Switch Node Ringing
- This Device is Pb-Free and is RoHS Compliant

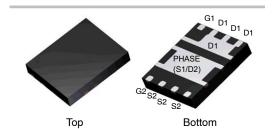
#### **Applications**

- Computing
- Communications
- General Purpose Point of Load
- Notebook VCORE



#### ON Semiconductor®

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PQFN8 5x6, 1.27P CASE 483AJ

#### **MARKING DIAGRAM**

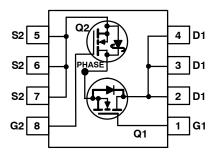
\$Y&Z&3&K 22CA N7CC

\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Numeric Date Code

&K = Lot Code

22CA N7CC = Specific Device Code

#### **PIN CONFIGURATION**



#### **ORDERING INFORMATION**

See detailed ordering and shipping information on page 2 of this data sheet.

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### MOSFET MAXIMUM RATINGS T<sub>A</sub> = 25°C Unless Otherwise Noted

Symbol	Parameter	Q1	Q2	Units
VDS	Drain to Source Voltage	30	30	V
Vost	Drain to Source Transient Voltage (t <sub>Transient</sub> < 100 ns)	33	33	V
Vgs	Gate to Source Voltage (Note 3)	±20	±20	V
I <sub>D</sub>	Drain Current -Continuous (Package limited)  T <sub>C</sub> = 25 °C	30	40	Α
	-Continuous (Silicon limited) $T_C = 25$ °C	60	130	
	-Continuous T <sub>A</sub> = 25 °C	13 (Note 1a)	23 (Note 1b)	
	-Pulsed	40	100	
Eas	Single Pulse Avalanche Energy	40 (Note 4)	60 (Note 5)	mJ
$P_{D}$	Power Dissipation for Single Operation T <sub>A</sub> = 25 °C	2.2 (Note 1a)	2.5 (Note 1b)	W
٠ ن	Power Dissipation for Single Operation T <sub>A</sub> = 25 °C	1.0 (Note 1c)	1.0 (Note 1d)	••
TJ, Тsтg	TSTG Operating and Storage Junction Temperature Range -55 to +150		+150	°C

#### THERMAL CHARACTERISTICS

Symbol	Parameter	Q1	Q2	Unit
Reja	Thermal Resistance, Junction to Ambient	57 (Note 1a)	50 (Note 1b)	°C/W
RеJA	Thermal Resistance, Junction to Ambient	125 (Note 1c)	120 (Note 1d)	
Rелс	Thermal Resistance, Junction to Case	3.5	2	

#### PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
22CA N7CC	FDMS3604S	Power 56	13"	12 mm	3000 Units

# **ELECTRICAL CHARACTERISTICS** $T_J = 25^{\circ}C$ Unless Otherwise Noted

$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Symbol	Parameter		mn Head Conditions	Туре	Min	Тур	Max	Units
Voltage   Vo	OFF CHAR	ACTERISTICS	•						
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	BV <sub>DSS</sub>								V
IGSS   Gate to Source Leakage Current, Forward   VGS = 20 V, VDS = 0 V   Q1   Q2   Q2   Q2   Q2   Q2   Q2   Q2									mV/°C
Forward   For	I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0$	V					μΑ
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	I <sub>GSS</sub>		$V_{GS} = 20 \text{ V}, V_{DS} = 0$	V					nA
D = 1 mA	ON CHARA	ACTERISTICS							
Temperature Coefficient   To = 10 mA, referenced to 25°C   Q2   -5   To S(en)	V <sub>GS(th)</sub>	Gate to Source Threshold Voltage		$\mu A V_{GS} = V_{DS}$ ,					V
D <sub>B</sub> = 11 A   V <sub>QS</sub> = 10 V, I <sub>D</sub> = 13 A , T <sub>J</sub> = 125°C   7.8   10.8   10.8   V <sub>QS</sub> = 10 V, I <sub>D</sub> = 23 A V <sub>QS</sub> = 4.5 V, I <sub>D</sub> = 21 A   V <sub>QS</sub> = 10 V, I <sub>D</sub> = 23 A , T <sub>J</sub> = 125°C   2.0   2.6   3.0   3.5   2.6   4   130	$\frac{\Delta V_{GS(th)}}{\Delta T_J}/$								mV/°C
	r <sub>DS(on)</sub>	Drain to Source On Resistance	I <sub>D</sub> = 11 A		Q1		8.5	11	mΩ
DYNAMIC CHARACTERISTICS   Cliss   Input Capacitance   Q1:   V <sub>DS</sub> = 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz   Q2   M310   M485   Q45   M310   M485   Q2   M310   M3240   M324			I <sub>D</sub> = 21 A		Q2		3.0	3.5	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	9FS	Forward Transconductance	V <sub>DS</sub> = 5 V, I <sub>D</sub> = 13 A V <sub>DS</sub> = 5 V, I <sub>D</sub> = 23 A						S
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	DYNAMIC (	CHARACTERISTICS				•			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	C <sub>iss</sub>	Input Capacitance	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ Q2:						pF
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	C <sub>oss</sub>	Output Capacitance							pF
	C <sub>rss</sub>	Reverse Transfer Capacitance							pF
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	$R_{g}$	Gate Resistance							Ω
$\begin{array}{cccccccccccccccccccccccccccccccccccc$	SWITCHING	G CHARACTERISTICS							
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 15 \text{ V}, I_D = 13 \text{ A}$	A, R <sub>GEN</sub> = 6 Ω					ns
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t <sub>r</sub>	Rise Time		A, $R_{GEN} = 6 \Omega$					ns
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	t <sub>d(off)</sub>	Turn-Off Delay Time							ns
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	t <sub>f</sub>	Fall Time							ns
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	Qg	Total Gate Charge	V <sub>GS</sub> = 0 V to 10 V	$V_{DD} = 15 \text{ V}, I_D = 13 \text{ A}$					nC
Q2         9           Qd         Gate to Drain "Miller" Charge         Q1         3.1         nC	Qg	Total Gate Charge	V <sub>GS</sub> = 0 V to 4.5 V	$V_{DD} = 15 \text{ V}, I_{D} = 23 \text{ A}$					nC
	$Q_{gs}$	Gate to Source Gate Charge							nC
	$Q_{gd}$	Gate to Drain "Miller" Charge							nC

#### **ELECTRICAL CHARACTERISTICS** T<sub>J</sub> = 25°C Unless Otherwise Noted (continued)

Symbol	Parameter	Column Head Test Conditions	Туре	Min	Тур	Max	Units
DRAIN-SOURCE DIODE CHARACTERISTICS							
$V_{SD}$	Source to Drain Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 13 A (Note 2) V <sub>GS</sub> = 0 V, I <sub>S</sub> = 23 A (Note 2)	Q1 Q2		0.8 0.8	1.2 1.2	V
t <sub>rr</sub>	Reverse Recovery Time	Q1 I <sub>F</sub> = 13 A, di/dt = 100 A/μs	Q1 Q2		25 32	40 51	ns
Q <sub>rr</sub>	Reverse Recovery Charge	Q2   I <sub>F</sub> = 23 A, di/dt = 300 A/μs	Q1 Q2		9 39	18 62	nC

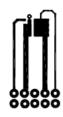
1.  $R_{\theta JA}$  is determined with the device mounted on a 1 in2 pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



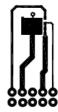
a. 57 °C/W when mounted on a 1 in2 pad of 2 oz copper



b. 50 °C/W when mounted on a 1 in<sup>2</sup> pad of 2 oz copper



c. 125 °C/W when mounted on a minimum pad of 2 oz copper



d. 120 °C/W when mounted on a minimum pad of 2 oz copper

- 2. Pulse Test: Pulse Width < 300  $\mu$ s, Duty cycle < 2.0%.
  3. As an N-ch device, the negative Vgs rating is for low duty cycle pulse ocurrence only. No continuous rating is implied.
  4.  $E_{AS}$  of 40 mJ is based on starting  $T_J$  = 25°C; N-ch: L = 1 mH,  $I_{AS}$  = 9 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V. 100% test at L = 0.3 mH,  $I_{AS}$  = 14 A.
  5.  $E_{AS}$  of 60 mJ is based on starting  $T_J$  = 25°C; N-ch: L = 1 mH,  $I_{AS}$  = 11 A,  $V_{DD}$  = 27 V,  $V_{GS}$  = 10 V. 100% test at L = 0.3 mH,  $I_{AS}$  = 18 A.

#### TYPICAL CHARACTERISTICS (Q1 N-CHANNEL)

 $T_J = 25^{\circ}C$  Unless Otherwise Noted

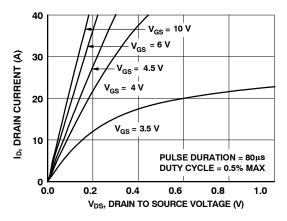


Figure 1. On-Region Characteristics

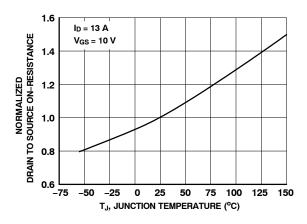


Figure 3. Normalized On Resistance vs Junction Temperature

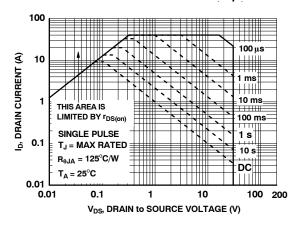


Figure 5. Transfer Characteristics

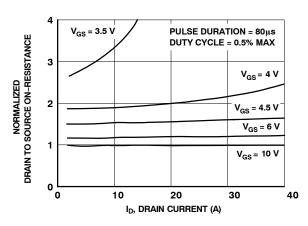


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

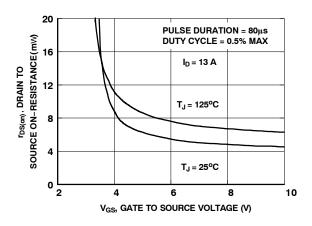


Figure 4. On–Resistance vs Gate to Source Voltage

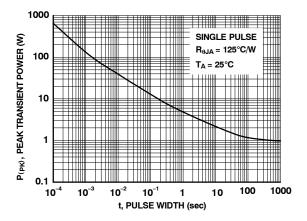


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

#### TYPICAL CHARACTERISTICS (Q1 N-CHANNEL)

T<sub>J</sub> = 25°C Unless Otherwise Noted (continued)

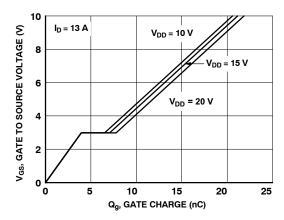


Figure 7. Gate Charge Characteristics

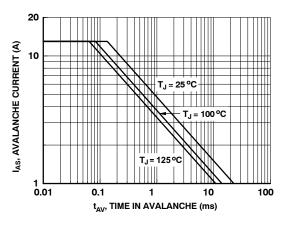


Figure 9. Unclamped Inductive Switching Capability

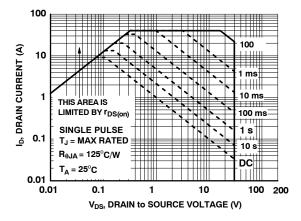


Figure 11. Forward Bias Safe Operating Area

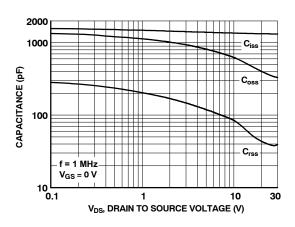


Figure 8. Capacitance vs Drain to Source Voltage

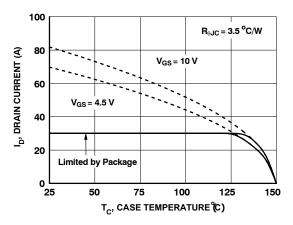


Figure 10. Maximum Continuous Drain Current vs Case Temperature

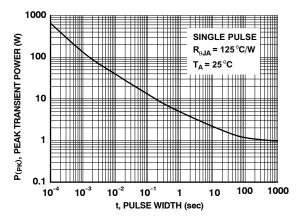


Figure 12. Single Pulse Maximum Power Dissipation

#### **TYPICAL CHARACTERISTICS (Q1 N-CHANNEL)**

 $T_J = 25^{\circ}C$  Unless Otherwise Noted (continued)

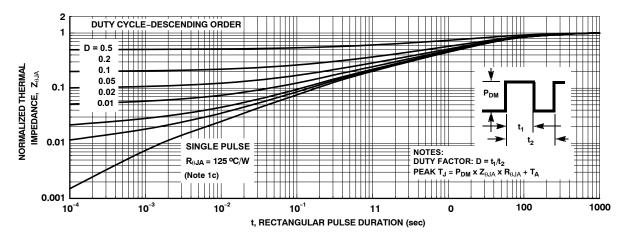


Figure 13. Junction-to-Ambient Transient Thermal Response Curve

#### TYPICAL CHARACTERISTICS (Q2 N-CHANNEL)

T<sub>J</sub> = 25°C Unless Otherwise Noted

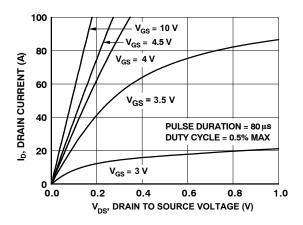


Figure 14. On-Region Characteristics

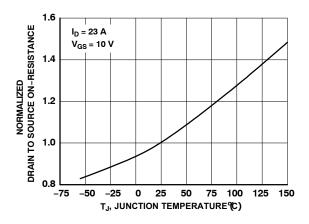


Figure 16. Normalized On–Resistance vs Junction Temperature

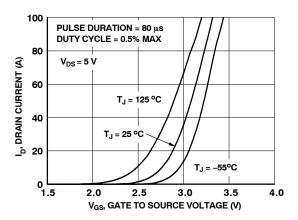


Figure 18. Transfer Characteristics

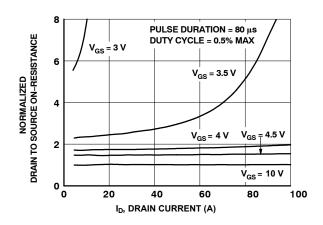


Figure 15. Normalized On-Resistance vs Drain Current and Gate Voltage

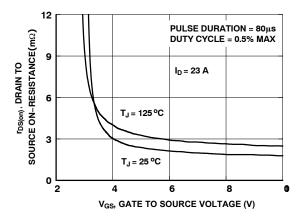


Figure 17. On-Resistance vs Gate to Source Voltage

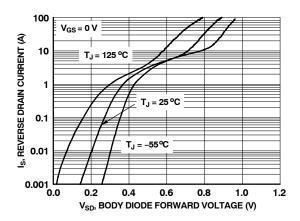


Figure 19. Source to Drain Diode Forward Voltage vs Source Current

#### **TYPICAL CHARACTERISTICS (Q2 N-CHANNEL)**

 $T_J = 25^{\circ}C$  Unless Otherwise Noted (continued)

10000

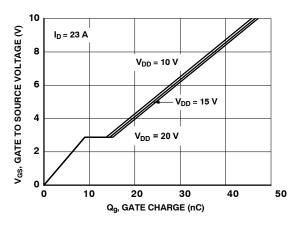
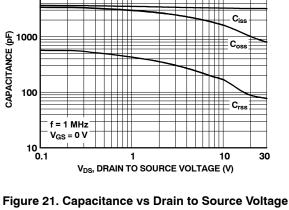


Figure 20. Gate Charge Characteristics



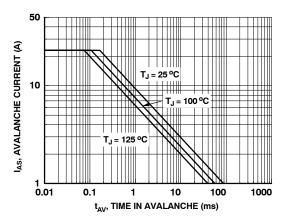


Figure 22. Unclamped Inductive Switching Capability

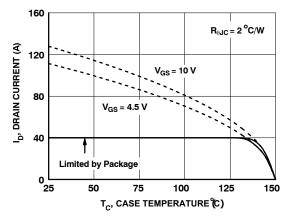


Figure 23. Maximum Continuous Drain Current vs Case Temperature

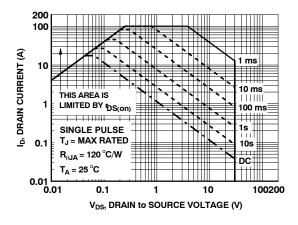


Figure 24. Forward Bias Safe Operating Area

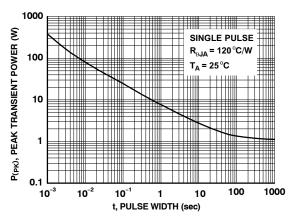


Figure 25. Single Pulse Maximum Power Dissipation

#### TYPICAL CHARACTERISTICS (Q2 N-CHANNEL)

T<sub>J</sub> = 25°C Unless Otherwise Noted (continued)

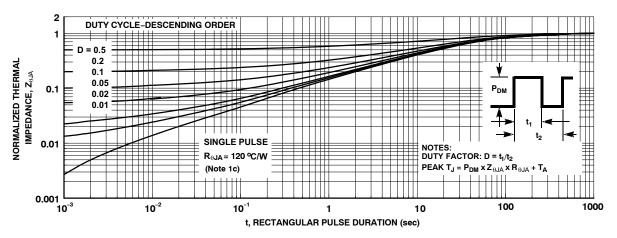


Figure 26. Junction-to-Ambient Transient Thermal Response Curve

#### **SyncFET Schottky Body Diode Characteristics**

ON Semiconductor's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 27 shows the reverse recovery characteristic of the FDMS3604S.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

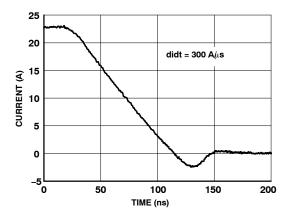


Figure 27. FDMS3604S SyncFET Body Diode Reverse Recovery Characteristics

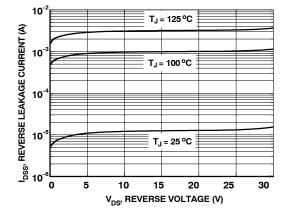


Figure 28. SyncFET Body Diode Reverse Leakage versus Drain-source Voltage

#### **APPLICATION INFORMATION**

#### **Switch Node Ringing Suppression**

ON Semiconductor's Power Stage products incorporate a proprietary design\* that minimizes the peak overshoot, ringing voltage on the switch node (PHASE) without the need of any external snubbing components in a buck

converter. As shown in the Figure 29, the Power Stage solution rings significantly less than competitor solutions under the same set of test conditions.

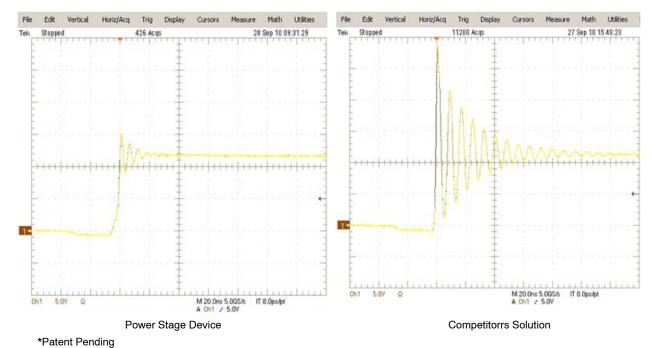


Figure 29. Power Stage Phase Node Rising Edge, High Turn On

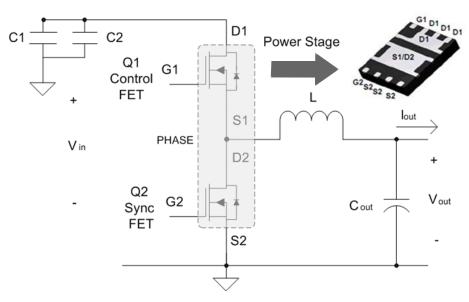
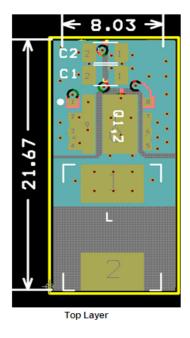


Figure 30. Shows the Power Stage in a Buck Converter Topology

#### **Recommended PCB Layout Guidelines**

As a PCB designer, it is necessary to address critical issues in layout to minimize losses and optimize the performance of the power train. Power Stage is a high power density solution and all high current flow paths, such as VIN (D1), PHASE (S1/D2) and GND (S2), should be short and wide

for better and stable current flow, heat radiation and system performance. A recommended layout procedure is discussed below to maximize the electrical and thermal performance of the part.



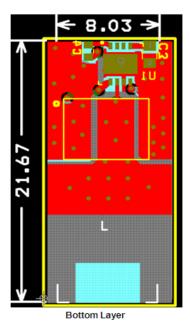


Figure 31. Recommended PCB Layout

Following is a guideline, not a requirement which the PCB designer should consider:

- 1. Input ceramic bypass capacitors C1 and C2 must be placed close to the D1 and S2 pins of Power Stage to help reduce parasitic inductance and High Frequency conduction loss induced by switching operation. C1 and C2 show the bypass capacitors placed close to the part between D1 and S2. Input capacitors should be connected in parallel close to the part. Multiple input caps can be connected depending upon the application
- 2. The PHASE copper trace serves two purposes; In addition to being the current path from the Power Stage package to the output inductor (L), it also serves as heat sink for the lower FET in the Power Stage package. The trace should be short and wide enough to present a low resistance path for the high current flow between the Power Stage and the inductor. This is done to minimize conduction losses and limit temperature rise. Please note that the PHASE node is a high voltage and high frequency switching node with high noise potential. Care should be taken to minimize coupling to adjacent traces. The reference layout in Figure 31 shows a good balance between the thermal and electrical performance of Power Stage
- 3. Output inductor location should be as close as possible to the Power Stage device for lower power loss due to copper trace resistance. A shorter and wider PHASE trace to the inductor reduces the conduction loss. Preferably the Power Stage should be directly in line (as shown in Figure 32) with the inductor for space savings and compactness
- 4. The POWERTRENCH Technology MOSFETs used in the Power Stage are effective at minimizing phase node ringing. It allows the part to operate well within the breakdown voltage limits. This eliminates the need to have an external snubber circuit in most cases. If the designer chooses to use an RC snubber, it should be placed close to the part between the PHASE pad and S2 pins to dampen the high-frequency ringing
- 5. The driver IC should be placed close to the Power Stage part with the shortest possible paths for the High Side gate and Low Side gates through a wide trace connection. This eliminates the effect of parasitic inductance and resistance between the driver and the MOSFET and turns the devices on and off as efficiently as possible. At

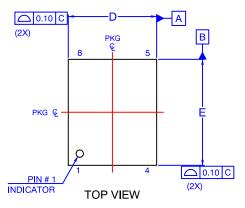
- higher-frequency operation this impedance can limit the gate current trying to charge the MOSFET input capacitance. This will result in slower rise and fall times and additional switching losses. Power Stage has both the gate pins on the same side of the package which allows for back mounting of the driver IC to the board. This provides a very compact path for the drive signals and improves efficiency of the part
- 6. S2 pins should be connected to the GND plane with multiple vias for a low impedance grounding. Poor grounding can create a noise transient offset voltage level between S2 and driver ground. This could lead to faulty operation of the gate driver and MOSFET
- 7. Use multiple vias on each copper area to interconnect top, inner and bottom layers to help smooth current flow and heat conduction. Vias should be relatively large, around 8 mils to 10 mils, and of reasonable inductance. Critical high frequency components such as ceramic bypass caps should be located close to the part and on the same side of the PCB. If not feasible, they should be connected from the backside via a network of low inductance vias

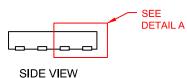
SyncFET IS trademark of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. POWERTRENCH is registered trademark of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries.

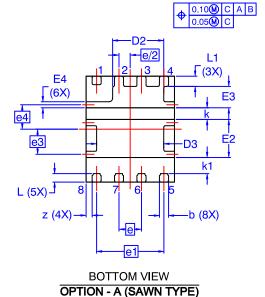


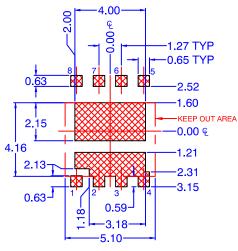
#### PQFN8 5X6, 1.27P (SAWN TYPE) CASE 483AJ ISSUE A

**DATE 08 FEB 2021** 



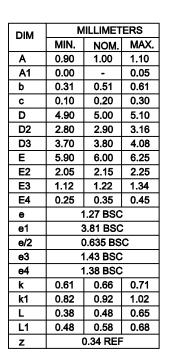






# LAND PATTERN RECOMMENDATION FOR SAWN / PUNCHED TYPE

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.



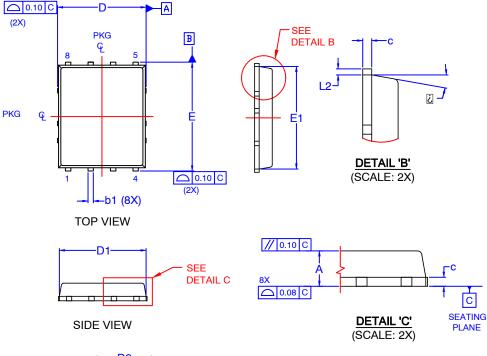
// 0.10 C			
8X A			
○ 0.08 C	<del>                                     </del>		C
	С¬	A1 <sup>-</sup>	SEATING
	DETAIL 'A' (SCALE: 2X)		PLANE

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DESCRIPTION:	PQFN8 5X6, 1.27P		PAGE 1 OF 2		

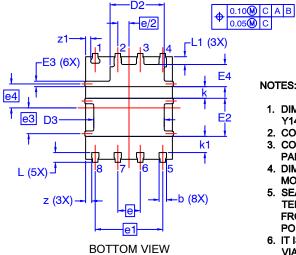
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#### PQFN8 5X6, 1.27P (PUNCHED TYPE) CASE 483AJ **ISSUE A**

**DATE 08 FEB 2021** 



DIM	MILLIMETERS				
Dilvi	MIN.	NOM.	MAX.		
Α	0.90	1.00	1.10		
b	0.31	0.51	0.61		
b1	0.21	0.31	0.41		
С	0.15	0.25	0.35		
D	4.90	5.00	5.10		
D1	4.80	4.90	5.00		
D2	2.80	3.06	3.16		
D3	3.70	3.98	4.08		
E	5.90	6.00	6.25		
E1	5.70	5.80	5.90		
E2	2.05	2.15	2.25		
E3	0.25	0.33	0.45		
E4	1.12	1.24	1.34		
е	•	.27 BSC	;		
e1	;	3.81 BSC	;		
e/2	(	0.635 BS	С		
e3	•	1.45 BSC	;		
e4	•	1.36 BSC	;		
k	0.61	0.66	0.71		
k1	0.82	0.92	1.02		
L	0.38	0.55	0.65		
L1	0.35	0.45	0.55		
L2	0.08	0.18	0.28		
z	0.34 REF				
z1	0.28 REF				
ө	0°	0° - 10°			



**OPTION - B (PUNCHED TYPE)** 

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- 4. DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- 5. SEATING PLANE IS DEFINED BY THE TERMINALS. "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.
- 6. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

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DESCRIPTION:	PQFN8 5X6, 1.27P	•	PAGE 2 OF 2

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